

# STS4DNFS30

# N-channel - 30V - 0.044Ω - 4.5A SO-8 STripFET™ Power MOSFET plus schottky rectifier

### **General features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
STS4DNFS30	30V	<0.055Ω	4.5A
Schottky	I <sub>F(AV)</sub>	$V_{RRM}$	$V_{F(MAX)}$
	4.5A	30V	0.53V

## **Description**

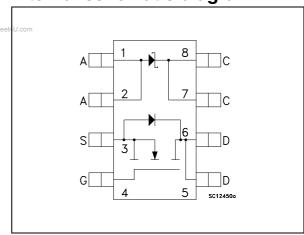
This product associates the latest low voltage STripFET™ in n-channel version to a low drop Schottky diode. Such configuration is extremely versatile in implementing a large variety of DC-DC converters for printers, portable equipment.

# SO-8

## **Applications**

Switching application

## Internal schematic diagram



#### **Order codes**

Part number	Marking	Package	Packaging
STS4DNFS30	S4DNFS30	SO-8	Tape & reel

Contents STS4DNFS30

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STS4DNFS30 Electrical ratings

# 1 Electrical ratings

Table 1. Mosfet absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	30	V
V <sub>GS</sub>	Gate- source voltage	± 20	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25°C	4.5	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100°C	3.2	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	13	Α
P <sub>TOT</sub>	Total dissipation at $T_C = 25^{\circ}C$	2	W

<sup>1.</sup> Pulse width limited by safe operating area

Table 2. Schottky absolute maximum ratings

Symbol	Parameter		Value	Unit
V <sub>RRM</sub>	Repetitive peak reverse voltage		30	V
I <sub>F(RMS)</sub>	RMS forward current		10	Α
I <sub>F(AV)</sub>	Average forward current	T <sub>L</sub> =125°C δ=0.5	4	Α
I <sub>FSM</sub>	Surge non repetitive forward current	tp=10ms Sinusoidal	75	Α
I <sub>RRM</sub>	Repetitive peak reverse current	tp=2µs F=1kHz	1	Α
I <sub>RSM</sub>	Non repetitive peak reverse current	tp=100µs	1	Α
dv/dt	Critical rate of rise of reverse voltage		10000	v/µs

Table 3. Thermal data

Symbol	Parameter	Value	Unit
Rthj-amb	Thermal resistance junction-amb Mosfet (1)	62.5	°C/W
T <sub>stg</sub>	Storage temperature range Max	-55 to 150	°C
T <sub>j</sub>	Junction temperature	-55 to 150	°C

<sup>1.</sup> Mounted on FR-4 board (steady state)

Electrical characteristics STS4DNFS30

# 2 Electrical characteristics

(Tcase =25°C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 250\mu A, V_{GS} = 0$	30			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	$V_{DS}$ = Max rating $V_{DS}$ = Max rating, $T_{C}$ =125°C			1 10	μ <b>Α</b> μ <b>Α</b>
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20V			± 100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	1			V
R <sub>DS(on)</sub>	Static drain-source on resistance	$V_{GS} = 10V$ , $I_D = 2A$ $V_{GS} = 5V$ , $I_D = 2A$		0.044	0.055 0.085	Ω Ω

Table 5. Static

Symbol	Parameter	Test conditions		Min.	Тур.	Max.	Unit
I <sub>R</sub> <sup>(1)</sup>	Reverse leakage current	$T_j = 25^{\circ}C$ $T_j = 100^{\circ}C$	$V_R = V_{RRM}$		6	200 15	μA mA
V <sub>F</sub> <sup>(1)</sup>	Zero gate voltage	I <sub>j</sub> = 125°C	I <sub>F</sub> = 2A		0.325	0.45 0.375	V V
<b>v</b> F`'	drain current ( $V_{GS} = 0$ )	$T_j = 25^{\circ}C$ $T_j = 125^{\circ}C$	I <sub>F</sub> = 4A		0.43	0.53 0.51	V V

<sup>1.</sup> Pulse test: tp=380 $\mu$ s,  $\delta$  < 2%. To evaluate the conduction losses use the following equation:

$$P = 0.24 \times I_{F(AV)} + 0.068I_{F^2}(RMS)$$

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub>	Forward transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =2A		5		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz, V}_{GS} = 0$		330 115 28		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 15V$ , $I_D = 4.5A$ , $V_{GS} = 5V$ (see Figure 13)		4.7 1.2 2.1		nC nC nC

Table 7. Switching times

	<u> </u>					
Symbol	Parameter	Test Conditions	Min.	Тур.	Max	Unit
t <sub>d(on)</sub>	Turn-on delay time Rise time	$V_{DD}$ = 15V, $I_D$ = 2A, $R_G$ = 4.7 $\Omega$ , $V_{GS}$ = 5V (see Figure 12)		9 17		ns ns
t <sub>d(off)</sub>	Turn-off delay time Fall time	$V_{DD}$ = 15V, $I_D$ = 2A, $R_G$ = 4.7 $\Omega$ , $V_{GS}$ = 5V (see <i>Figure 12</i> )		15 6		ns ns

Table 8. Source drain diode

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current				4.5	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)				13	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 4.5A, V_{GS} = 0$			1.2	V
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 4.5A$ , di/dt = 100A/ $\mu$ s		22		ns
$Q_{rr}$	Reverse recovery charge	V <sub>DD</sub> = 15V, T <sub>j</sub> = 150°C		14.3		nC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 17)		1.3		Α

<sup>1.</sup> Pulse width limited by safe operating area

<sup>2.</sup> Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5 %

Electrical characteristics STS4DNFS30

## 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

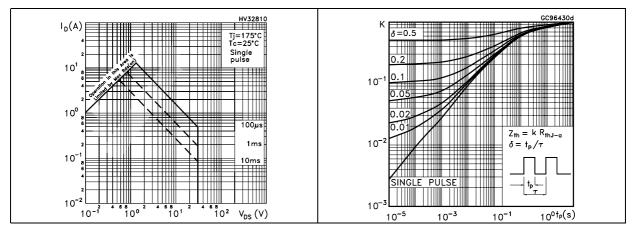


Figure 3. Output characterisics

Figure 4. Transfer characteristics

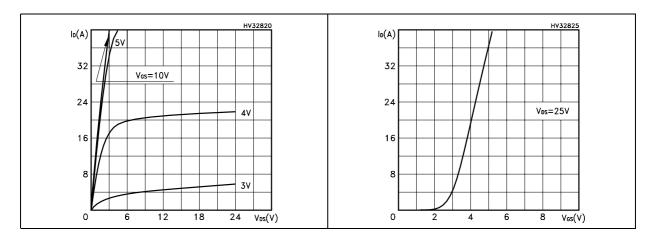


Figure 5. Source-drain diode forward characteristics

Figure 6. Static drain-source on resistance

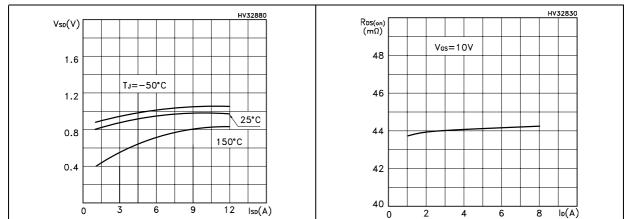


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

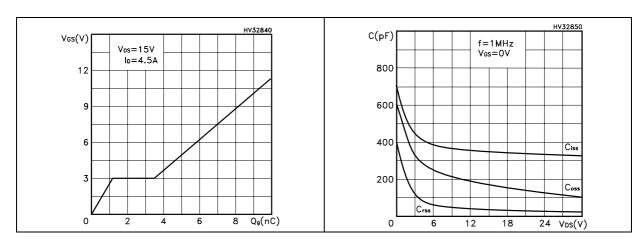


Figure 9. Normalized gate threshold voltage Figure 10. Normalized on resistance vs vs temperature temperature

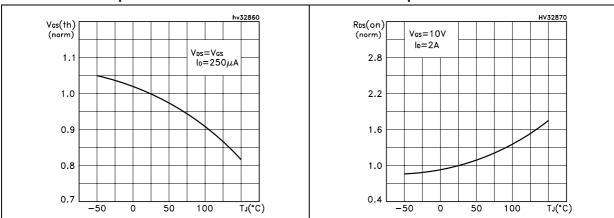
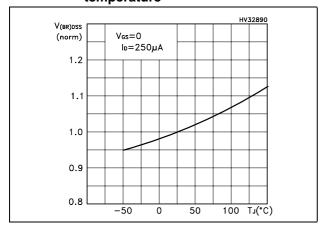


Figure 11. Normalized BV<sub>DSS</sub> voltage vs temperature



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Test circuits STS4DNFS30

## 3 Test circuits

Figure 12. Switching times test circuit for resistive load

Figure 13. Gate charge test circuit

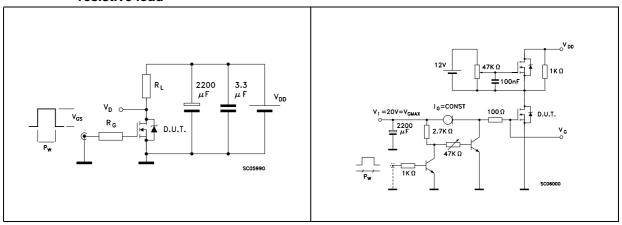


Figure 14. Test circuit for inductive load switching and diode recovery times

Figure 15. Unclamped inductive load test circuit

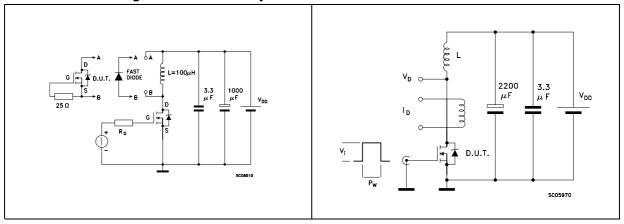
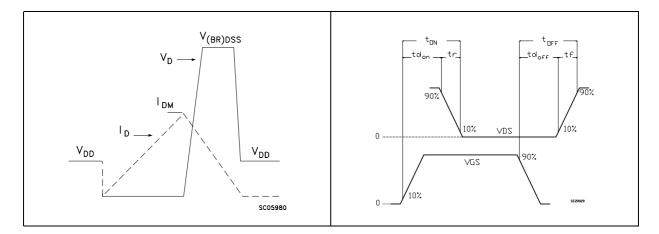


Figure 16. Unclamped inductive waveform

Figure 17. Switching time waveform



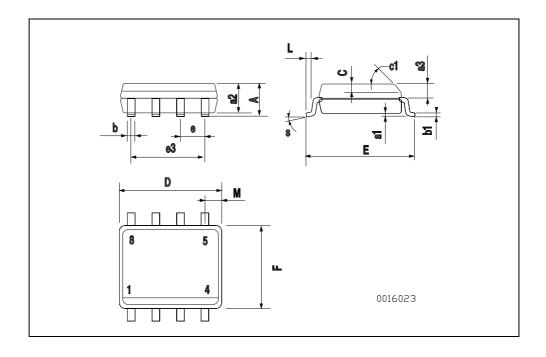
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# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: <a href="https://www.st.com">www.st.com</a>

## **SO-8 MECHANICAL DATA**

DIM	mm.			inch			
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.	
Α			1.75			0.068	
a1	0.1		0.25	0.003		0.009	
a2			1.65			0.064	
a3	0.65		0.85	0.025		0.033	
b	0.35		0.48	0.013		0.018	
b1	0.19		0.25	0.007		0.010	
С	0.25		0.5	0.010		0.019	
c1			45	(typ.)			
D	4.8		5.0	0.188		0.196	
Е	5.8		6.2	0.228		0.244	
е		1.27			0.050		
e3		3.81			0.150		
F	3.8		4.0	0.14		0.157	
L	0.4		1.27	0.015		0.050	
М			0.6			0.023	
S		•	8 (r	nax.)	•	•	



STS4DNFS30 Revision history

# 5 Revision history

Table 9. Revision history

Date	Revision	Changes
19-Jul-2005	1	First release

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